

High Speed IGBT Chip in NPT-technology

FEATURES:

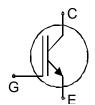
- low Eoff
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient easy paralleling

This chip is used for:

• SGW50N60HS

Applications:

- Welding
- PFC
- UPS



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code	
SIGC42T60UN	600V	50A	6.5 x 6.5 mm ²	sawn on foil	SP0001-01820	

MECHANICAL PARAMETER:

Raster size	6.5 x 6.5				
Area total / active	42.25 / 35.6				
Emitter pad size	2x(3.0x2.85)				
Gate pad size	0.8 x 1.5				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	334				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag -system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	150	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_{j}, T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter		Conditions	min.	typ.	max.	01
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V, I_{C} =2mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =50A		2.8	3.15	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=1mA$, $V_{GE}=V_{CE}$	3	4	5	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V			40	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V, V _{GE} =20V			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailletei			min.	typ.	max.	Oilit
Input capacitance	Ciss	V _{CE} =25V	-	2572		pF
Output capacitance	Coss	V _{GE} =0V	-	245		
Reverse transfer capacitance	Crss	f=1MHz	-	158		

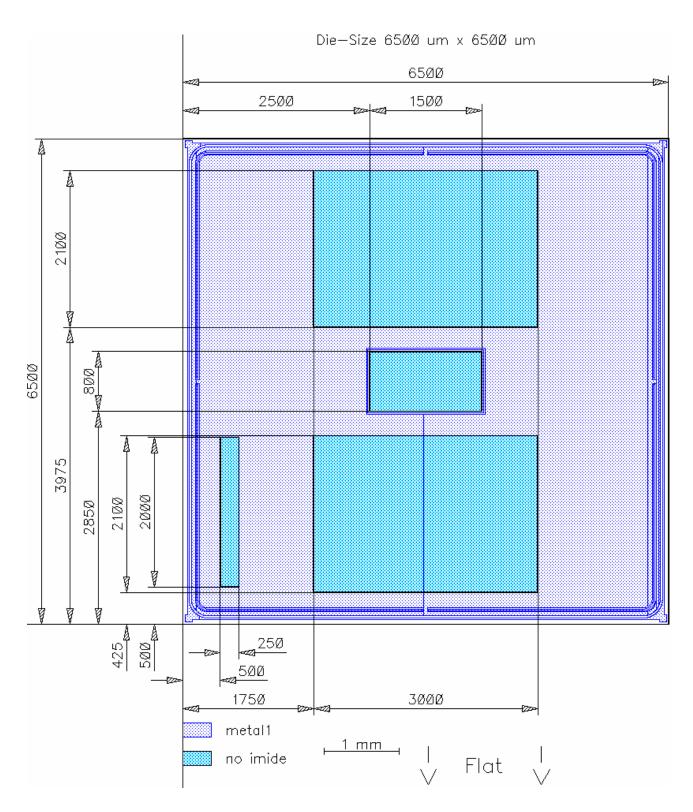
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions*	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	$T_{\rm j}$ =150°C $V_{\rm CC}$ =400V	1	48		ns
Rise time	t_{r}	/ _C =50A	ı	31		
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE} = +15/0 \rm V$ $R_{\rm G} = 6.8 \Omega$	1	350		
Fall time	t_{f}	, 10 - 0 : 022	ı	20		

^{*} Values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet SGW50N60HS Package :TO247

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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